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Carly Sun 10Gtek Transceivers Co. Ltd info@10gtek.com October 23, 2018

Enclosed are the results from the Open Network Systems Interoperability performed on:

Module or Cable Assembly Under Test (MUT/CUT):

Vendor and Device Type	10Gtek SFP+
Part Number	AXS85-192-M3

Host Under Test (HUT):

Host System 1 Composition				
Network Operating System	Cumulus			
OS Version	3.4			
Bare Metal Switch	Accton AS5712			
Part Number	5712			
ONIE Version	2018.02			

This testing pertains to the Open Network Systems Interoperability Test Plan, which outlines a series of tests performed on a variety of optical transceivers and cables with bare-metal open switches running Network Operating Systems from multiple vendors. The focus of these tests was basic interoperability, which aims to validate the operation of open network systems.

As always, we welcome any comments regarding this Test Suite. If you have any questions about the test procedures or results, please feel free to contact me via e-mail at david@iol.unh.edu or by phone at +1-603-862-0090.

Regards, David Woolf

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In section 2, the following equipment was used:

Test System Hardware	
EEPROM Reader	I2C Elite Reader

In section 3, the following equipment was used:

Test System Hardware	
Network Analyzer	PNA –Performance Network Analyzer

In section 4, the following equipment was used:

Test System Hardware						
Wide Bandwidth Oscilloscope	Keysight DCA-X 86100D Wide Bandwidth Oscilloscope					
Waveform Analyzer	Keysight 86105C Optical Waveform Analyzer					
50GHz Waveform Analyzer	Keysight 86108B Mega Module, 50GHz Bandwidth Waveform Analyzer					
Clock Recovery Module	Keysight 83496B Optical/Electrical Clock Data Recovery Unit					
High Performance Serial BERT	Tektronix BERTScope					
Signal Quality Analyzer	BERTScope PRBS9 at 10.3125Gbps					
De-Emphasis Signal Converter	Agilent N4916B					

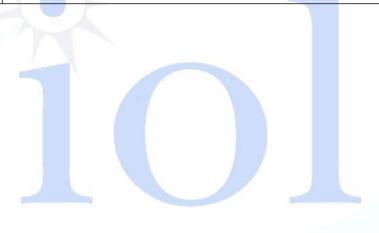
^{*}Two modules used during testing

In section 6, an Ostinato was used to generate test traffic:

Test System Hardware	
Ethernet Traffic Generator	10Gb Ethernet Network Adapter Card
Software Version	Ostinato
Port Types	10G SFP, 40G QSFP

The following table contains possible results and their meanings.

Result	Interpretation				
PASS	The Device Under Test (DUT) was observed to exhibit conformant behavior.				
PASS W/ Comments	The specified behavior is demonstrated by the DUT; however this result indicates that either changes were made to the standard test procedure or results other than the expected results were observed.				
FAIL	The DUT was observed to exhibit non-compliant behavior.				
INFO	This Test is designed for informational purposes only. While the results may help ensure the interoperability of the DUT, a PASS/FAIL is not given for this test.				
WARN	The DUT was observed to exhibit behavior that is not recommended.				
N/A	Not Applicable. This test is not applicable for the DUT.				
N/S	Not Supported. This test was not run due to features not implemented on the DUT.				
N/T	Not tested. This test was not run.				



Cumulus 3.4 | Accton 5712 | 10Gtek Transceivers Co. Ltd AXS85-192-M3 Open Network Systems Interoperability Test Report

Summary of Results- Conformance				
Test	Result			
Test 1.1: ONIE Compliance Environment	N/A			
Test 1.2: Installing and uninstalling a NOS through ONIE via HTTP server	PASS			
Test 3.1.1: Return Loss for 10G Passive Cable	PASS			
Test 3.1.2: Insertion Loss for 10G Passive Cable	PASS			
Test 5.1.1: Output Rise and Fall Times for 100G Host	PASS			
Test 5.1.2: Transmitter Eye Mask for 100G Host	PASS			
Test 5.1.3: Total Jitter for 100G Host	PASS			
Test 5.1.4: Input and Output Return Loss on 100G Host	PASS			

Summary of Results - Interoperability					
Test	Result				
Test 2.1: Physical Compatibility with Supporting Devices	PASS				
Test 2.2: Host Management of Module or Cable Assembly	PASS				
Test 2.3: Diagnostic Optical Monitor Support	PASS				
Test 6.1: Establish Baseline Performance Analysis	PASS				
Test 6.2: Link Detection on Power Up	PASS				
Test 6.3:Packet Error Rate Estimation	PASS				
Test 6.4: Packet Loss/Stress Test	PASS				

Notes						
			1			

Conformance Test Results			
Test Information	Test Result		
Test 1.1: ONIE Compliance Environment			
<i>Purpose</i> : To verify that a host can pass a random sampling of ONIE Compliance Environment tests.	N/A		
Comments on Test Procedure			
The random sampling of tests from the ONIE Compliance Environment was not used. Comments on Test Results			
Additional Comments			
This test is only applicable to Hosts which have not performed ONIE compliance previously.	ance testing		

Test Information	Test Result
Test 1.2: Installing and uninstalling a NOS through ONIE via HTTP server Purpose: To verify that a NOS can be successfully installed through ONIE.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure as written in the Test Plan. The rand the ONIE Compliance Environment was not used.	lom sampling of tests from
Comments on Test Results	
Part A: The DUT was able to install the NOS via ONIE. Part B: The DUT was able to uninstall the NOS via ONIE.	
Additional Comments	

Test Information	Test Result
Test 3.1.1: Return loss for 10G Passive Cable	
<i>Purpose</i> : To verify that the return loss of the DUT is within the conformance limits provided by SFF-8431 Appendix E, Table 37.	PASS

Comments on Test Procedure

This test was completed using the standard procedure.

Comments on Test Results

The differential return loss observed did not violate the limits governed by SFF-8431 Appendix E.4, Table 37 for 10GBASE-CR passive cables:

$$12 - 2\sqrt{}, \qquad 0.01 \le < 4.1$$

$$11, \qquad 22 \ge \{ \\ 6.3 - 13 \log_{10} 5.5, \qquad 4.1 \le \le 11.1 \} ()$$

Additional Comments

Test Information	Test Result
Test 3.1.2: Insertion Loss for 10G Passive Cable	
<i>Purpose</i> : To verify that the insertion loss of the Cable under test is within the conformance limits provided by IEEE Std. 802.3-2012 Annex, Table 37.	PASS

Comments on Test Procedure

This test was completed using the standard procedure.

Comments on Test Results

The insertion loss of the cable under test does not violate the requirements passive cable assemblies.

$$3 \leq 21, \quad 12 \leq 17.04, \quad 5.15625$$

Additional Comments

Test Information	Test Result
Test 5.1.1: Output Rise and Fall Times for 10G Host	
Purpose: To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	J
The test was completed with the standard procedure.	
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	

Test Information	Test Result
Test 5.1.2: Transmitter Eye Mask on 10G Host Purpose: To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure. Comments on Test Results The device under test exhibited the expected behavior.	
Additional Comments	
	,

Test Information	Test Result	
Test 5.1.3: Total Jitter for 10G Host		
Purpose: To verify that the Total Jitter (TJ) is within the conformance limit.	PASS	
Comments on Test Procedure		
The test was completed with the standard procedure.		
Comments on Test Results		
The device under test exhibited the expected behavior.		
Additional Comments		

Test Information	Test Result
Test 5.1.4: Input and Output Return Loss on 10G Host	- 3
Purpose: To verify that the differential input and output return loss of the DUT is within conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure. Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	
See Appendix B	

Interoperability Test Results		
Test Information	Test Result	
Test 2.1: Physical Compatibility with Supporting Devices		
<i>Purpose</i> : To verify that the mechanical form factor is compatible with devices for interoperability purposes.	PASS	
Comments on Test Procedure		
The test was completed with the standard procedure. Comments on Test Results		
Part A: The MUT/CUT was able to be inserted into the Host.		
Part B: This test is not applicable to Cable Assemblies. Part C: The MUT/CUT was able to be removed from the Host.		
Additional Comments		

Test Information	Test Result
Test 2.2: Host Management of Module or Cable Assembly Purpose: To verify that the MUT/CUT is manageable via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
Part B: The EEPROM data of the MUT/CUT was readable. The serial number and ventor information of the EEPROM data matches the serial number and vendor information of the Additional Comments.	
Additional Comments	

Test Information	Test Result
Test 2.3: Diagnostic Optical Monitor Support	
<i>Purpose</i> : To verify that the MUT/CUT (active optical cable only) supports diagnostic functions via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
Part A: The MUT/CUT supports diagnostic monitoring and the diagnostic information from readable by the NOS.	the EEPROM was
Additional Comments	

Test Information	Test Result
Test 6.1: Establish Baseline Performance Analysis	DAGG
<i>Purpose</i> : To establish a baseline performance analysis of the HUT.	PASS
Comments on Test Procedure	d «

This test was completed using a modified procedure. Because of a lack of 40G Golden Modules, the Host was baselined using each 40G MUT/CUT.

Comments on Test Results

The baseline performance of the Host was determined to be 90% line rate. All proceeding tests in Group 6 were conducted using this line rate.

Additional Comments

Test Information		Test Result
Test 6.2: Detection or	Power Up	
Purpose: To determine power up sequence.	f the MUT/CUT, HUT and LP establish a link while varying the	PASS

Comments on Test Procedure

This test was completed using the standard procedure.

Comments on Test Results

- **Part A:** The Host and Link Partner were able to establish a valid link with this MUT/CUT while fully powered and operational.
- **Part B:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Link Partner was powered on after the Host.
- **Part C:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Host was powered on after the Link Partner.

Additional Comments

Test Information	Test Result
Test 6.3:Packet Error Rate Estimation	
<i>Purpose</i> : To determine if a Host can exchange packets with a Module or Cable Assembly such that a bit error rate of 10 ⁻¹² is achieved	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
Part A: All 247,000,000 frames transmitted by TS1 were received by TS2. Part B: All 10,506,539,320 frames transmitted by TS1 were received by TS2.	
Additional Comments	

Test Information	Test Result
Test 6.4: Packet Loss/Stress Test Purpose: To verify that no obvious buffer management problems occur when directing a large volume of traffic at the Host and Module/Cable Assembly combination.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2. All 1,000,000,000 1518-byte frames transmitted by TS1 were received by TS2.	
Additional Comments	

Appendix A: EEPROM Data

10Gtek SFP/SFP+/SFP28 module

Part Number: AXS85-192-M3 Serial Number: WTSSRHA0141

10Gtek WTSSRHA0141 EEPROMdecode 20180831161546.txt

SERIAL_ID Keys: BR_MAX: 10300 BR_MIN: 10300 BR_NOMINAL: 10300 CABLE_SPEC: 0x0 0x0 CONNECTOR: 7

DATE_CODE: 171001

DIAGNOSTIC MONITORING TYPE: 104

ENCODING: 6

ENHANCED_OPTIONS: 0 EXT_IDENTIFIER: 4 IDENTIFIER: 3 LENGTH_50UM: 80 LENGTH_62_5UM: 20 LENGTH_OM3: 300 LENGTH_OM4_OR_CU: 0

LENGTH_SMF: 0
LENGTH_SMF_KM: 0
OPTIONS: 0x0 0x0
RATE_IDENTIFIER: 0
SFF_8472_COMPLIANCE: 8

TRANSCEIVER: 0x10 0x0 0x0 0x0 0x44 0x0 0xc 0xd5

TRANSCEIVER_EXT: 0 VENDOR_NAME: 10Gtek VENDOR_OUI: 0x0 0x0 0x0 VENDOR_PN: AXS85-192-M3

VENDOR REV: V01

VENDOR SN: WTSSRHA0141

WAVELENGTH: 850

I2C Address A0h, bytes 0-127, in hex

0000x: 03040710 00000044 000cd506 67000000 0010x: 0802001e 31304774 656b2020 20202020 0020x: 20202020 00000000 41585338 352d3139 0030x: 322d4d33 20202020 56303120 0352007f 0040x: 00000000 57545353 52484130 31343120 0050x: 20202020 31373130 30312020 6800086c 0060x: 00000000 00000000 00000000 0070x: 00000000 00000000 00000000 00000000

I2C Address A2h, bytes 0-127, in hex

0000x: 5a00f600 5500fb00 8ca07530 8<u>8b87724</u>

0010x: 61a801f4 4e2003e8 312d0497 271005c7 0020x: 312d01ea 27100269 00000000 00000000 0030x: 00000000 00000000 00000000 0040x: 00000000 3f800000 00000000 01000000 0050x: 01000000 01000000 01000000 0100000 015c1829e 0b981496 00010000 00000200 0070x: 00400000 00400000 00000000 00000000

Appendix B: Pluggable Module / Cable Electrical Data

Generated by Viavi 5800-100G

Optics Self-Test

Customer Name	**
Technician ID	**
Test Location	46
Work Order	**
Comments/Notes	**

Overall Test Result: Pass

Appendix C: Host Electrical Data

